

March 2008

NC7WZ00 TinyLogic[®] UHS Dual 2-Input NAND Gate

Features

- Space saving US8 surface mount package
- MicroPak[™] leadless package
- Ultra High Speed; t_{PD} 2.4ns typ. into 50pF at 5V V_{CC}
- High Output Drive; ±24mA at 3V V_{CC}
- Broad V_{CC} Operating Range; 1.65V–5.5V
- Matches the performance of LCX when operated at 3.3V V_{CC}
- Power down high impedance inputs/output
- Overvoltage tolerant inputs facilitate 5V to 3V translation
- Patented noise/EMI reduction circuitry implemented

General Description

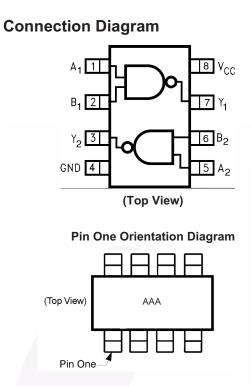
The NC7WZ00 is a dual 2-Input NAND Gate from Fairchild's Ultra High Speed Series of TinyLogic®. The device is fabricated with advanced CMOS technology to achieve ultra high speed with high output drive while maintaining low static power dissipation over a broad V_{CC} operating range. The device is specified to operate over the 1.65V to 5.5V V_{CC} operating range. The inputs and output are high impedance when V_{CC} is 0V. Inputs tolerate voltages up to 7V independent of V_{CC} operating voltage.

Ordering Information

Order Number	Package Number	Product Code Top Mark	Package Description	Supplied As
NC7WZ00K8X	MAB08A	WZ00	8-Lead US8, JEDEC MO-187, Variation CA 3.1mm Wide	3k Units on Tape and Reel
NC7WZ00L8X	MAC08A	N6	8-Lead MicroPak, 1.6 mm Wide	5k Units on Tape and Reel

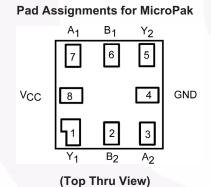
Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering number.

All packages are lead free per JEDEC: J-STD-020B standard.



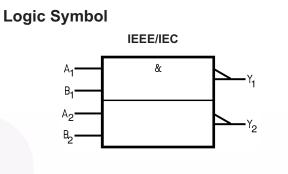
AAA represents Product Code Top Mark – see ordering code

Note: Orientation of Top Mark determines Pin One location. Read the top product code mark left to right, Pin One is the lower left pin (see diagram).



Pin Description

Pin Names	Description
A _n , B _n	Inputs
Y _n	Output



Function Table



Inp	outs	Output
Α	В	Y
L	L	Н
L	Н	Н
Н	L	Н
Н	Н	L

H = HIGH Logic Level

L = LOW Logic Level

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter	Rating
V _{CC}	Supply Voltage	–0.5V to +7V
V _{IN}	DC Input Voltage	–0.5V to +7V
V _{OUT}	DC Output Voltage	–0.5V to +7V
I _{IK}	DC Input Diode Current @ V _{IN} < -0.5V	–50mA
I _{OK}	DC Output Diode Current @ V _{OUT} < -0.5V	–50mA
I _{OUT}	DC Output Current	±50mA
I _{CC} /I _{GND}	DC V _{CC} /GND Current	±100mA
T _{STG}	Storage Temperature	–65°C to +150°C
Tj	Junction Temperature Under Bias	150°C
TL	Junction Lead Temperature (Soldering, 10 seconds)	260°C
PD	Power Dissipation @ +85°C	250mW

Recommended Operating Conditions⁽¹⁾

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to absolute maximum ratings.

Symbol	Parameter	Rating	
V _{CC}	Supply Voltage Operating	1.65V to 5.5V	
	Supply Voltage Data Retention	1.5V to 5.5V	
V _{IN}	Input Voltage	0V to 5.5V	
V _{OUT}	Output Voltage 0V		
T _A	Operating Temperature	–40°C to +85°C	
t _r , t _f	Input Rise and Fall Time		
	$V_{CC} = 1.65V \pm 0.15V$, 2.5V $\pm 0.2V$	0ns/V to 20ns/V	
	V _{CC} = 3.3V ±0.3V 0ns/V		
	$V_{CC} = 5.0V \pm 0.5V$	0ns/V to 5ns/V	
θ _{JA}	Thermal Resistance	250°C/W	

Note:

1. Unused inputs must be held HIGH or LOW. They may not float.

					T _A = 25°C		T _A = -40°C to +85°C			
Symbol	Parameter	V _{CC} (V)	(V) Conditions		Min.	Тур.	Max.	Min.	Max.	Units
	HIGH Level	1.65–1.95			0.75 x V _{CC}			0.75 x V _{CC}		V
	Input Voltage	2.3–5.5	1		0.70 x V _{CC}			0.70 x V _{CC}		
V _{IL}	LOW Level	1.65–1.95					0.25 x V _{CC}		0.25 x V _{CC}	V
	Input Voltage	2.3–5.5					0.30 x V _{CC}		0.30 x V _{CC}	1
V _{OH}	HIGH Level	1.65	$V_{IN} = V_{IL}$	$V_{\rm IN} = V_{\rm IL}$ $I_{\rm OH} = -100 \mu A$	1.55	1.65		1.55		V
	Output Voltage	2.3			2.2	2.3		2.2		1
		3.0			2.9	3.0		2.9		1
		4.5			4.4	4.5		4.4		1
		1.65		I _{OH} = -4mA	1.29	1.52		1.69		1
		2.3		I _{OH} =8mA	1.9	2.15		1.9		1
	3.0		I _{OH} = -16mA	2.4	2.80		2.4		1	
	3.0	-	I _{OH} = -24mA	2.3	2.68		2.3		1	
		4.5		I _{OH} = -32mA	3.8	4.20		3.8		1
V _{OL}	LOW Level	1.65	$V_{IN} = V_{IH}$	I _{OL} = 100μA		0.0	0.1		0.1	V
	Output Voltage	2.3				0.0	0.1		0.1	1
		3.0	-			0.0	0.1		0.1	1
		4.5	-			0.0	0.1		0.1	1
		1.65		I _{OL} = 4mA		0.08	0.24		0.24	1
		2.3	-	I _{OL} = 8mA		0.10	0.3		0.3	1
		3.0		I _{OL} = 16mA		0.15	0.4		0.4	1
		3.0		$I_{OL} = 24mA$		0.22	0.55		0.55	1
	4.5	-	I _{OL} = 32mA		0.22	0.55		0.55	1	
I _{IN}	Input Leakage Current	0–5.5	V _{IN} = 5.5V,	GND			±0.1		±1	μA
I _{OFF}	Power Off Leakage Current	0.0	V _{IN} or V _{OU} .	_T = 5.5V			1		10	μA
Icc	Quiescent Supply Current	1.65–5.5	V _{IN} = 5.5V,	GND			1		10	μA

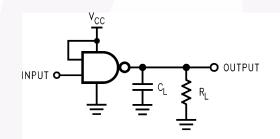
AC	Electrical	Characteristics

				Τ ₄	x = +2 5	°C		–40°C 85°C		Figure
Symbol	Parameter	V _{CC} (V)	Conditions	Min.	Тур.	Max.	Min.	Max.	Units	Number
t _{PLH} , t _{PHL}	Propagation Delay	1.8 ± 0.15	$C_L = 15 pF$,	2.0	5.3	9.6	2.0	9.8	ns	Figure 1
		2.5 ± 0.2	$R_L = 1M\Omega$	1.2	3.2	5.3	1.2	5.7		Figure 3
		3.3 ± 0.3		0.8	2.4	3.7	0.8	4.0	1	
		5.0 ± 0.5		0.5	1.9	2.9	0.5	3.2]	
t _{PLH} , t _{PHL}	Propagation Delay	3.3 ± 0.3	$C_L = 50 pF$,	1.2	3.0	4.6	1.2	4.9	ns	Figure 1
		5.0 ± 0.5	$R_L = 500\Omega$	0.8	2.4	3.6	0.8	3.9		Figure 3
C _{IN}	Input Capacitance	0			2.5				pF	
C _{PD}	Power Dissipation	3.3	(2)		13				pF	Figure 2
	Capacitance	5.0			17					

Note:

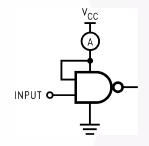
2. C_{PD} is defined as the value of the internal equivalent capacitance which is derived from dynamic operating current consumption (I_{CCD}) at no output loading and operating at 50% duty cycle. (See Figure 2.) C_{PD} is related to I_{CCD} dynamic operating current by the expression: $I_{CCD} = (C_{PD})(V_{CC})(f_{IN}) + (I_{CC} \text{static})$.

AC Loading and Waveforms



 C_L includes load and stray capacitance Input PRR = 1.0 MHz; $t_w = 500 \text{ns}$

Figure 1. AC Test Circuit



Input = AC Waveform; $t_r = t_f = 1.8$ ns; PRR = 10 MHz; Duty Cycle = 50%

Figure 2. I_{CCD} Test Circuit

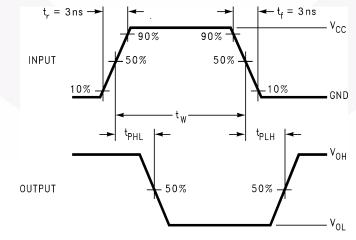


Figure 3. AC Waveforms

Tape and Reel Specifications

Tape Format for US8

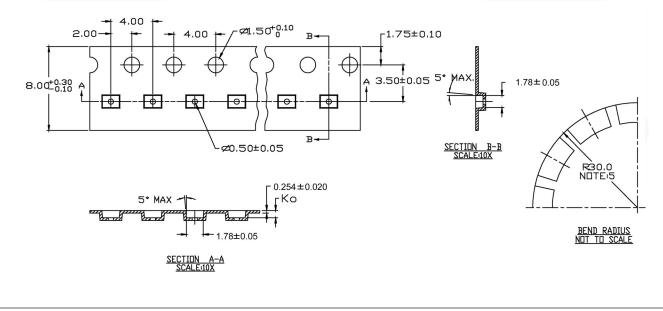
Package Designator	Tape Section	Number of Cavities	Cavity Status	Cover Tape Status
K8X	Leader (Start End)	125 (typ.)	Empty	Sealed
	Carrier	3000	Filled	Sealed
	Trailer (Hub End)	75 (typ.)	Empty	Sealed

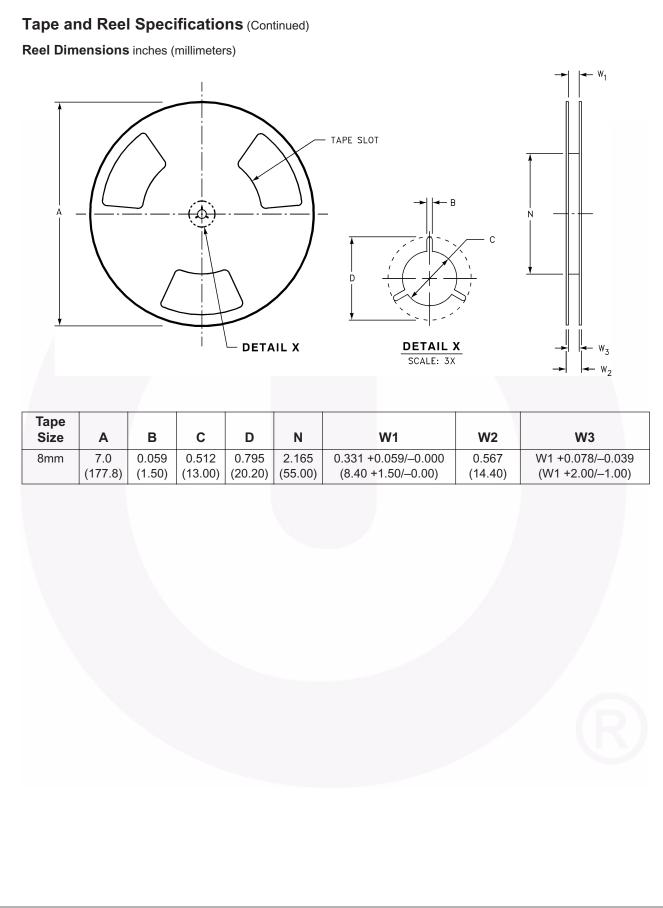
Tape Dimensions inches (millimeters)

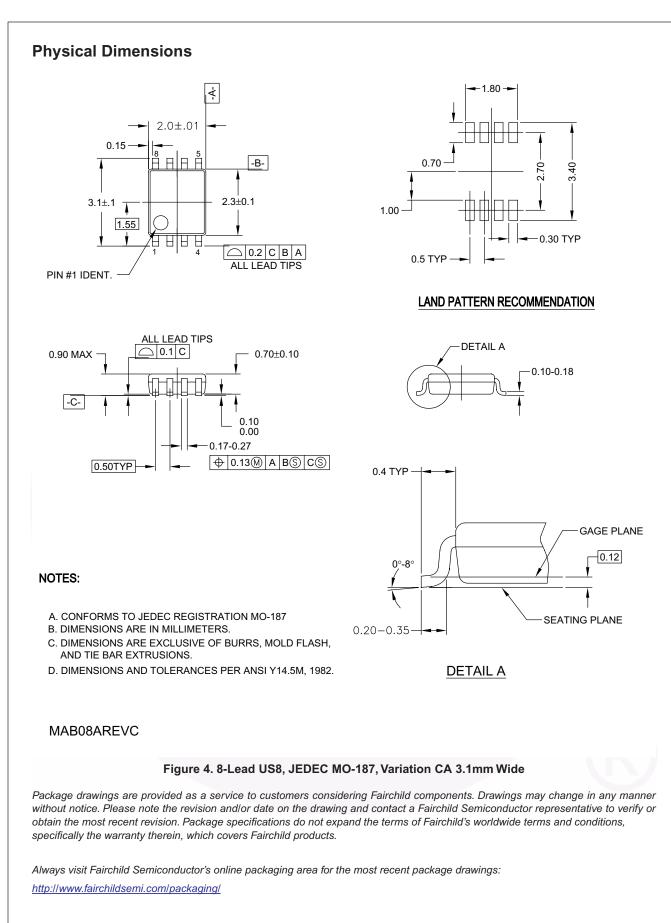
Tape Format for MicroPak

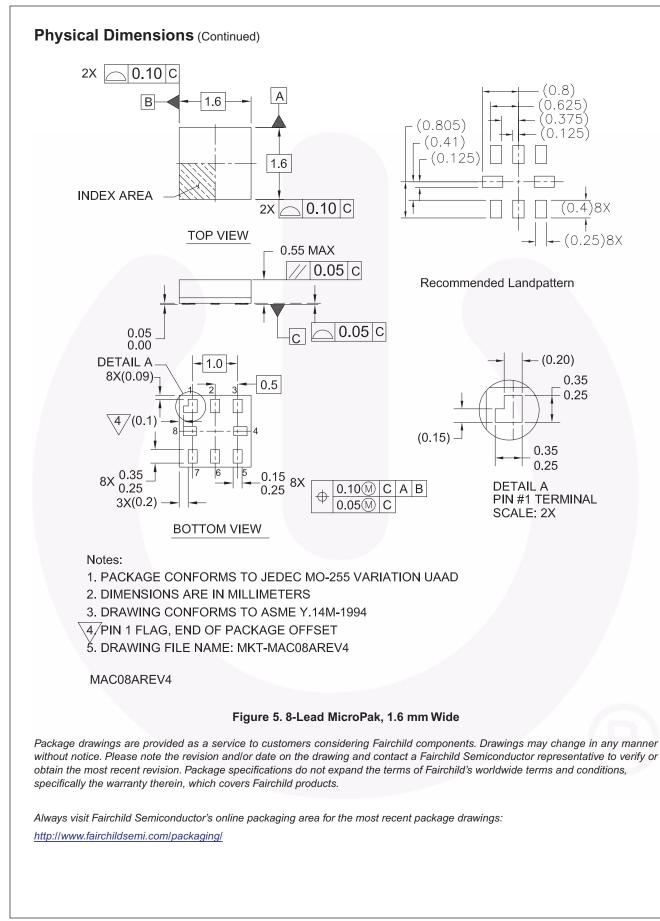
Package Designator	Tape Section	Number of Cavities	Cavity Status	Cover Tape Status
L8X	Leader (Start End)	125 (typ.)	Empty	Sealed
	Carrier	3000	Filled	Sealed
	Trailer (Hub End)	75 (typ.)	Empty	Sealed

Tape Dimensions inches (millimeters)











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